

Form PTO-1449 (REV. 8-83)		US Dept. of Commerce PATENT & TRADEMARK OFFICE		ATTY DOCKET NO. 117025	APPLICATION NO. 10/671,786		
INFORMATION DISCLOSURE STATEMENT <i>(Use several sheets if necessary)</i>		<i>NOV 01 2005 P.T.O. 1449 PATENT & TRADEMARK OFFICE</i>		APPLICANT(S) Kazuma AOKI et al.			
				FILING DATE September 29, 2003	GROUP 2151		
U.S. PATENT DOCUMENTS							
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME		CLASS	SUB CLASS
/JP/		2001/0048744 A1	12-06-2001	Kimura			
/JP/		2002/0110123 A1	08-15-2002	Shitama			
FOREIGN PATENT DOCUMENTS							
		DOCUMENT NUMBER	DATE	COUNTRY		CLASS	SUB CLASS
/JP/		JP-A-2001-345819	12-14-2001	Japan (with abstract and translation)			
/JP/		JP-A-2002-152279	05-24-2002	Japan (with abstract and translation)			
/JP/		EP-A2-1 161 031	12-05-2001	Europe			
/JP/		EP-A3-1 161 031	12-05-2001	Europe			
OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, etc.)							
EXAMINER		/Jayesh Patel/			DATE CONSIDERED		05/10/2007
Examiner: Initial if citation considered, whether or not citation is in conformance with M.P.E.P. 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.							

Date: November 1, 2005

Substitute for Form 1449 A & B/PTO				Complete if Known	
INFORMATION DISCLOSURE STATEMENT BY APPLICANT				Application Number	Unknown
(use as many sheets as necessary)				Confirmation Number	Not yet assigned
				Filing Date	September 29, 2003
				First Named Inventor	Hideyuki SAKAIDA
				Art Unit	Not yet assigned
				Examiner Name	Not yet assigned
Sheet	1	of	1	Attorney Docket Number	Q77624

NON PATENT LITERATURE DOCUMENTS			
Examiner Initials*	Cite No. ¹	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city, and/or country where published.	Translation*
/JP/		B.E. ALLMAN, et al. "NONINTERFEROMETRIC QUANTITATIVE PHASE IMAGING WITH SOFT X RAYS" J. OPT. SOC. AM. A/VOL. 17, No. 10/October 2000	Article
/JP/		T.E. GUREYEV, et. al. "HARD X RAY QUANTITATIVE NON-INTERFEROMETRIC PHASE-CONTRAST IMAGING", PART OF SPIE CONFERENCE ON PHYSICS OF MEDICAL IMAGING, Feb. 1999	Article
/JP/		T.E. GUREYEV, et al. "QUANTITATIVE IN-LINE PHASE-CONTRAST IMAGING WITH MULTIERGY X RAYS", PHYSICS REVIEW LETTERS, VOL. 86, No. 25, 18 June, 2001	Article

Examiner Signature	/Jayesh Patel/	Date Considered	05/10/2007
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*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

¹Applicant's unique citation designation number (optional). ²See Kind Codes of USPTO Patent Documents at www.uspto.gov, MPEP 901.04 or in the comment box of this document.
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